## Applicant(s)/Patent Under Reexamination Application/Control No. 10/004,312 NEMIROVSKY, YAEL **Notice of References Cited** Examiner Art Unit Page 1 of 1 Akm Enayet Ullah 2874

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0009256	01-2002	Chertkow et al.	385/18
	В	US-6,535,663	03-2003	Chertkow, Igal Roberto	385/18
	С	US-6,574,026	06-2003	Jin et al.	359/224
	D	US-6,498,870	12-2002	Wu et al.	385/18
	Е	US-5,930,531	07-1999	Kitagawa et al.	396/55
	F	US-6,297,072	10-2001	Tilmans et al.	438/106
	G	US-4,061,485	12-1977	Rimmel, Carl F.	65/377
	П	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
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	Р					,
	Ø					
	R					
	S					
	Т					,

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	Х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.